

<b>Notice of References Cited</b>	Application/Control No. 10/761,962		Applicant(s)/Patent Under Reexamination TAKIZAWA ET AL.	
	Examiner Rene Towa		Art Unit 3736	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,143,082 A	09-1992	Kindberg et al.	600/562
*	B	US-5,147,371 A	09-1992	Washington et al.	606/127
*	C	US-5,336,227 A	08-1994	Nakao et al.	606/114
*	D	US-5,941,896 A	08-1999	Kerr, Andrew	606/200
*	E	US-5,993,469 A	11-1999	McKenzie et al.	606/159
*	F	US-6,165,200 A	12-2000	Tsugita et al.	606/200
*	G	US-6,245,088 B1	06-2001	Lowery, Samuel R.	606/200
*	H	US-6,319,268 B1	11-2001	Ambrisco et al.	606/200
*	I	US-6,620,182 B1	09-2003	Khosravi et al.	606/200
*	J	US-2003/0176884 A1	09-2003	Berrada et al.	606/200
*	K	US-6,632,175 B1	10-2003	Marshall, Daniel R.	600/309
*	L	US-6,632,171 B2	10-2003	Iddan et al.	600/106
*	M	US-6,884,213 B2	04-2005	Raz et al.	600/104

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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